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John Berndner, Jens C. Boemer, Babak Enayati, Bob Fox, Mark Siira, *Vice Chairs*
Charles K. Vartanian, *Secretary*

Marcelo Algrain	Jonathan Gay	Prasad PMSVSV
Jose Aliaga-Caro	Ken Gebauer	Jim Reilly
Steven Allmond	Bo Gong	Mike Ruppert
Daniel Arjona	Robin Gray	Janette Sandberg
Thomas Basso	Kyle Hawkins	Joe Schaefer
Robert Bridges	Anderson Hoke	Ronald Shipman
Ken Brunkenhoefer	Fred Horton	George Shu
Sean Carr	Gregory Kern	David Smith
Frances Cleveland	Eric Le Curtois	Gary Smullin
Michael Coddington	Paul Leufkens	Wayne Stec
Nancy Connelly	Brian Lydic	Sylvester Toe
Patrick Dalton	Jason Marena	Reigh Walling
Mamadou Diong	Edward Morro	Bekki Watkins
Christian Eder	Dan Mungovan	Robert White
Doug Edwards	Arun Narang	Nicolas Wrathall
Antti Eerola	Alex Nassif	Yaosuo (Sonny) Xue
David Erhart	Coung Nguyen	Li Yu
Shalom Flank	Nayeem Ninad	Jimmy Zhang
Haile Gashaw		Kun Zhu

The following members of the individual Standards Association balloting group voted on this standard. Balloters may have voted for approval, disapproval, or abstention.

Robert Aiello	Paul Cardinal	Jorge Fernandez Daher
Ali Al Awazi	Sean Carr	Joshua Filler
Mihaela Albu	Juan Carreon	Curtis Fischer
Roy Alexander	Pin Chang	Keith Flowers
Marcelo Algrain	Wen-Kung Chang	David Forrest
Saleman Alibhay	Ke Chen	Rostyslaw Fostiak
Steven Allmond	Frances Cleveland	Gary Fox
Jay Anderson	Michael Coddington	Bob Fox
Daniel Arjona	Kent Coldsnow	Hailegebriel Gashaw
Curtis Ashton	Nancy Connelly	Jonathan Gay
Thomas Barnes	Larry Conrad	Ken Gebauer
Jeffrey Barsch	Stephen Conrad	Tim Godfrey
Michael Basler	Luis Coronado	Sigifredo Gonzalez
Thomas Basso	Randall Crellin	J.T. Gordon
John Berndner	Timothy Croushore	Lou Grahor
David Blackledge	Patrick Dalton	Stephen Grier
Jens Boemer	Ratan Das	Randall Groves
Brian Boysen	Mamadou Diong	John Harley
Chris Brooks	Kevin Donahoe	Kyle Hawkings
David Brown	Neal Dowling	Steven Hensley
Ken Brunkenhoefer	Herbert Dreyer	Mariana Hentea
Demetrio Bucaneg Jr.	Paul Duncan	Lee Herron
Jeffrey Burnworth	Michael Edds	Rodrigo Hidalgo
Ted Burse	Antti Eerola	Michael Higginson
William Byrd	Zakia El Omari	Werner Hoelzl
Mario Manana Canteli	Kevin Fellhoelter	Robert Hoerauf

Anderson Hoke
Keith Houser
Dmitry Ishchenko
Richard Jackson
Michael Jensen
Anthony Johnson
Gerald Johnson
Joseph Johnson
Innocent Kamwa
Peter Kelly
Sheldon Kennedy
Gregory Kern
Tanuj Khandelwal
Yuri Khersonsky
Amin Khodaei
James Kinney
Boris Kogan
Lawrence Kotewa
Paul Krell
Benjamin Kroposki
Jim Kulchisky
Chung-Yiu Lam
Raluca Lascu
Wei-Jen Lee
Andrew Levitt
Brian Lydic
Bruce Mackie
Reginaldo Maniego
Bradley Marszalkowski
Todd Martin
Barry Mather
James Mcconnach
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Hank McGlynn
Michael Mcinerney
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James Mirabile
Jeff Mizener

Edward Morrow
Charles Morse
Daniel Mungovan
Jerry Murphy
R. Murphy
Arun Narang
David Narang
Alexandre Nassif
Cuong Nguyen
James Niemira
Joe Nims
Nayeem Ninad
Chenhui Niu
Gregory Olson
Lorraine Padden
Bansi Patel
Dipesh Patel
Marc Patterson
Dean Philips
Jeannie Piekarz
James Reilly
Charles Rogers
Benjamin Rolfe
Mike Ruppert
Gregory Ryan
Daniel Sabin
Janette Sandberg
Kenneth Sanders
Steven Sano
Surya Santoso
Bartien Sayogo
Joseph Schaefer
Rebecca Schulz
Ulrich Schwabe
Kenneth Sedziol
Daniel Seidel
Robert Seitz
John Seuss
Nikunj Shah
Mohsen Sheikholeslamzadeh

Ronald Shipman
Gregory Shirek
Hyeong Sim
Jerry Smith
Mark Smith
Gary Smullin
Aaron Snyder
Wayne Stec
Marcus Steel
Michael Stephens
Clayton Stice
K. Stump
Charles Sufana
Chase Sun
David Tepen
Michael Thesing
Michael Thompson
Sylvester Toe
Maria Tome
Francois Trichon
Craig Turner
Demetrios Tziouvaras
Eric Udren
Timothy Unruh
James Van De Ligt
Benton Vandiver
Luis Vargas
Charlie Vartanian
S. Venkata
John Vergis
Dr. Simon Wall
Reigh Walling
John Wang
Keith Waters
Robert White
Kevin Whitener
Allen Windhorn
Nicolas Wrathall
Stephen Wurmlinger
Oren Yuen
Nicholas Zagrodnik

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Philip B. Winston
Daidi Zhong
Jingyi Zhou

*Member Emeritus

Introduction

This introduction is not part of IEEE 1547a™-2020, IEEE Standard for Interconnection and Interoperability of Distributed Energy Resources with Associated Electric Power Systems Interfaces—Amendment 1 to IEEE Std 1547-2018 to provide more flexibility for adoption of abnormal operating performance Category III.

This amendment of IEEE Std 1547™-2018 is intended to maintain harmonization of DER interconnection and interoperability requirements across the jurisdictions applying IEEE Std 1547-2018. Without this amendment, stakeholders in the process of adopting IEEE Std 1547-2018 may be forced to add their own, regionally-specific requirements, which could either complicate or even contradict the requirements specified in IEEE Std 1547-2018. This amendment provides more flexibility for adoption of abnormal operating performance Category III with wider ranges of allowable trip settings for UV1 and UV2 clearing times, and thereby broadens and simplifies the adoption of the standard.

This amendment is anticipated to increase the deployment of DER with Category III capabilities that can provide the highest bulk system reliability, compared to DER that is capable of the lower Category II. This amendment allows for voltage trip clearing times *inside* the ride-through capability regions of Category III-capable DER to achieve safe and reliable coordination of DER ride-through with prevailing distribution protection objectives and practices. The amendment can also lead to increased deployment of DER that address integration issues such as power quality and distribution grid or substation overloads caused by DER tripping in local Area EPS that have very high levels of DER penetration.

The approval and publication dates of this amendment were intended to harmonize with the drafting and application of regional reliability guidelines by regional reliability coordinators in North America ([B1], [B9], [B6], [B7]), and the publication and implementation of test and verification for IEEE Std 1547-2018 compliant DER equipment as specified in a revised IEEE Std 1547.1™.^{1,2} Learnings from latest research, leading industry practices, and specific case studies substantiate the need for and direction of this amendment ([B1], [B2], [B3], [B3], [B5], [B8]).

Acknowledgments

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¹ This may also pertain to certification of inverter-based DER as specified in a revised UL 1741 certification standard.

² The numbers in brackets correspond to those of the bibliography in Annex A.

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